

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Present Application:

Applicants: Douglas D. Do and Jeff C. Johnson
Attorney Docket No.: 500414.02
Date : July 31, 2000
Title : METHOD AND APPARATUS FOR MEASURING FEATURES OF A
SEMICONDUCTOR DEVICE

Prior Application:

Examiner : Craig Thompson
Art Unit : 2813
Serial No. : 09/083,835

PRELIMINARY AMENDMENT

Box Patent Application
Assistant Commissioner of Patents
Washington, D.C. 20231

Sir:

Prior to substantive examination, please amend the above-identified application as follows:

In the Title:

Amend the title of the application to read --APPARATUS FOR MEASURING FEATURES OF A SEMICONDUCTOR DEVICE-- in each place where it appears

In the Specification:

Amend the specification by inserting a new section before the "Technical Field" as follows: